Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application.

Listing of Claims:

Claim 1 (Currently amended): A microelectronic contact structure, comprising:

a plurality of substantially rigid column elements, each of said plurality of column elements comprising:

a core element <u>comprising a segment of wire</u> attached at a first end to a terminal of an electronic component, and

an over coat covering at least a portion of said core element, wherein said core element comprises a first material and said over coat comprises a second material, and said first material is one of softer, less rigid, or has a lower modulus of elasticity than said second material; and

a contact element joined to a second end of each of said column elements.

Claim 2 (Original): The microelectronic contact structure of Claim 1, wherein said contact element further comprises a beam formed of a resilient material.

Claim 3 (Previously presented): The microelectronic contact structure of Claim 1, wherein said contact element further comprises a contact pad joined to each of said column elements.

Claim 4 (Original): The microelectronic contact structure of Claim 1, wherein said column elements are substantially straight and parallel to one another.

Claim 5 (Previously presented): The microelectronic contact structure of Claim 2, wherein said beam is positioned transverse to each of said plurality of column elements and joined to each of said column elements.

Claim 6 (Previously presented): The microelectronic contact structure of Claim 1, wherein said column elements are inclined to said contact element at an angle between 70° and 110° excluding 90°.

Claim 7 (Original): The microelectronic contact structure of Claim 1, wherein said column elements are perpendicular to said contact element.

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Claim 8 (Original): The microelectronic contact structure of Claim 1, wherein each of said column elements is substantially cylindrical.

Claim 9 (Withdrawn): The microelectronic contact structure of Claim 2, wherein said beam is sloped away from said column elements.

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Claim 10 (Previously presented): The microelectronic contact structure of Claim 2, further comprising a sacrificial substrate joined to said beam.

Claim 11 (Withdrawn): The microelectronic contact structure of Claim 2, wherein said beam is contoured.

Claim 12 (Canceled)

Claim 13 (Original): The microelectronic contact structure of Claim 2, wherein said beam is fabricated by a lithographic process that includes depositing said resilient material on a sacrificial substrate.

Claim 14 (Previously presented): The microelectronic contact structure of Claim 2, further comprising a tip structure positioned on a surface of said beam opposite to said plurality of column elements.

Claim 15 (Canceled)

Claim 16 (Withdrawn): The microelectronic contact structure of Claim 15, further comprising a substrate joined to each of said column elements at said base thereof, wherein said plurality of column elements are arranged in a group and configured such that said top of each of said column elements will deflect towards said substrate when a force towards said substrate is applied to said tip, whereby said microelectronic contact structure is resilient.

Claim 17 (Withdrawn): The microelectronic contact structure of Claim 16, wherein said beam has a free end cantilevered from said plurality of column elements.

Claim 18 (Withdrawn): The microelectronic contact structure of Claim 17, further comprising a tip structure positioned on said beam between said free end of said beam and said plurality of column elements.

Claim 19 (Withdrawn): The microelectronic contact structure of Claim 18, wherein said tip structure is positioned on a surface of said beam opposite to said group of column elements.

Claim 20 (Withdrawn): The microelectronic contact structure of Claim 18, wherein said tip structure is positioned adjacent to said free end of said beam.

Claim 21 (Withdrawn): The microelectronic contact structure of Claim 18, wherein said tip structure comprises a stand-off mounted to said beam, and a contact tip mounted to said stand-off.

Claim 22 (Amended): A microelectronic contact structure, comprising:

a plurality of column elements, wherein each of said plurality of column elements has a column element comprising a top and a base, and wherein said bases are base is positioned for attachment to a substrate; and

a contact element joined to each of said tops of said column elements said top of said column element,

wherein each of said column elements said column element comprises a wire core enclosed in a shell-comprising at least one shell-material.

Claims 23-29 (Canceled)

Claim 30 (Original): The microelectronic contact structure of Claim 1, further comprising said substrate joined to each of said column elements at said base thereof.

Claim 31 (Original): The microelectronic contact structure of Claim 2, further comprising said substrate joined to each of said column elements at said base thereof, and wherein said beam has a free end cantilevered from said group of column elements.

Claim 32 (Original): The microelectronic contact structure of Claim 31, wherein said microelectronic spring structure is configured such that said top of each of said column elements is substantially fixed while said free end of said beam will deflect under a force applied to said beam at said free end in a direction transverse to said substrate.

Claim 33 (Amended): The microelectronic contact structure of Claim 32, wherein A microelectronic contact structure, comprising:

a plurality of substantially rigid column elements, each of said plurality of column elements comprising:

a core element attached at a first end to a terminal of an electronic component, and

an over coat covering at least a portion of said core element, wherein said core element comprises a first material and said over coat comprises a second material, and said first material is one of softer, less rigid, or has a lower modulus of elasticity than said second material; and

a contact element joined to a second end of each of said column elements,

further comprising said substrate joined to each of said column elements at said
base thereof, and wherein said beam has a free end cantilevered from said group of column
elements,

wherein said microelectronic spring structure is configured such that said top of each of said column elements is substantially fixed while said free end of said beam will deflect under a force applied to said beam at said free end in a direction transverse to said substrate, and

each of said column elements is connected at said base thereof to a terminal of said substrate, and further comprising a connector comprising a wire core joined to said terminal of said substrate, and connected to a second terminal of said substrate.

Claim 34 (Canceled)

Claim 35 (Amended): A substrate having a plurality of microelectronic spring structures mounted thereto, wherein each of said microelectronic spring structures comprises:

a group of at least two substantially rigid column elements, wherein each column element element element element element at said base; and is joined to said substrate at said base;

a core element attached at a first end to a terminal of said substrate, and an over coat covering at least a portion of said core element, wherein said core element comprises a first material and said over coat comprises a second material, and said first material is one of softer, less rigid, or has a lower modulus of elasticity than said second material; and

a beam comprising a column connection region and a contact tip region and joined to each of said column elements in said group adjacent to a second end thereof, whereby at said column connection region, wherein said beam is positioned transverse to each of said column elements and said column elements are positioned such that the top of one of said column elements is positioned between the top of said other column element and the contact tip region of said beam.

Claim 36 (Original): The substrate of Claim 35, wherein said substrate comprises a probe card.

Claim 37 (Original): The substrate of Claim 35, wherein said substrate comprises a semiconductor material containing an integrated circuit.

Claim 38 (Original): The substrate of Claim 35, wherein said substrate comprises an interposer.

Claim 39 (Original): The substrate of Claim 35, wherein said substrate comprises a space transformer.

Claim 40 (Original): The substrate of Claim 35, wherein said substrate comprises an electrical connector.

Claim 41 (Original): A substrate-mounted microelectronic spring structure, comprising: a substrate;

a substantially rigid column element having a top and a base, and joined at said base to said substrate, wherein said column element comprises a substantially straight segment of wire; and

a resilient cantilevered beam having a free end, and joined to said top of said column element at a joint a distance away from said free end;

wherein said microelectronic spring structure is configured such that said top of said column element is substantially fixed while said cantilever beam permits elastic deflection of said free end thereof under a force applied to said beam at said free end towards said substrate.

Claim 42 (Previously presented): The microelectronic spring structure of Claim 41, wherein said column element is inclined to said beam at an angle between 70° and 110° excluding 90°.

Claim 43 (Withdrawn): The microelectronic spring structure of Claim 41, wherein said resilient cantilevered beam is sloped away from said substrate

Claim 44 (Withdrawn): The microelectronic spring structure of Claim 41, wherein said resilient cantilevered beam is contoured in a direction perpendicular to said substrate.

Claim 45 (Original): The microelectronic spring structure of Claim 41, wherein said resilient cantilevered beam is fabricated by a lithographic process that includes depositing said resilient material on a sacrificial substrate.

Claim 46 (Original): The microelectronic spring structure of Claim 41, further comprising a tip structure positioned on a surface of said beam opposite to said column element.

Claim 47 (Original): The microelectronic spring structure of Claim 41, wherein said tip structure is positioned adjacent to said free end of said beam.

Claim 48 (Original): The microelectronic spring structure of Claim 47, wherein said tip structure comprises a stand-off mounted to said beam, and a contact tip mounted to said stand-off.

Claim 49 (Original): The microelectronic spring structure of Claim 41, wherein said column element comprises a wire core enclosed in a shell comprising at least one shell material.

Claim 50 (Original): The microelectronic spring structure of Claim 49, wherein said shell is formed by plating said shell material onto said wire cores.

Claim 51 (Original): The microelectronic spring structure of Claim 49, wherein said wire core is ball-bonded to said substrate.

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Claims 52-60 (Canceled)

Claim 61 (Amended): A microelectronic spring structure, comprising:

substrate means for supporting a structure:

support means for supporting a beam, for securing a beam to said substrate means, and for elevating a beam above said substrate means, wherein said support means comprises at least one substantially rigid column element having an at least partially over coated core element, wherein said core element comprises a first material and said over coat comprises a second material, and said first material is one of softer, less rigid, or has a lower modulus of elasticity than said second material; and

resilient beam means for contacting an electronic component, said resilient beam means supported by said support means.

wherein said core element of said at least one column element comprises a segment of wire.

Claim 62 (Previously presented): The microelectronic spring structure of Claim 61, wherein said support means comprises a group of said substantially rigid column elements.

Claim 63 (Original): The microelectronic spring structure of Claim 61, wherein said resilient beam means comprises a substantially straight beam of resilient material.

Claim 64 (Withdrawn): The microelectronic spring structure of Claim 61, wherein said resilient beam means comprises a beam of resilient material contoured in a direction perpendicular to said substrate.

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Claim 65 (Canceled)

Claim 66 (Original): The microelectronic spring structure of Claim 61, further comprising contact tip means for contacting a terminal of an electronic component, said contact tip means supported by and secured to said resilient beam means.

Claim 67 (Original): The microelectronic spring structure of Claim 66, wherein said contact tip means comprises a stand-off, and a contact tip mounted to said stand-off.

Claim 68 (Withdrawn): The substrate-mounted microelectronic spring structure of Claim 41 further comprising a plurality of said column elements.

Claim 69 (Previously presented): The substrate-mounted microelectronic spring structure of Claim 41, wherein said substrate-mounted microelectronic spring structure includes only one column element.

Claim 70 (Previously presented): The microelectronic contact structure of claim 1, wherein said first material is softer than said second material.

Claim 71 (Previously presented): The microelectronic contact structure of claim 1, wherein said first material is less rigid than said second material.

Claim 72 (Previously presented): The microelectronic contact structure of claim 1, wherein said first material has a lower modulus of elasticity than said second material.

Claim 73 (Previously presented): The microelectronic contact structure of claim 1, wherein said over coat anchors said core element to said terminal of said electronic component.

Claims 74-80 (Canceled)

Claim 81 (Previously presented): The microelectronic spring structure of claim 61, wherein said first material is softer than said second material.

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Claim 82 (Previously presented): The microelectronic spring structure of claim 61, wherein said first material is less rigid than said second material.

Claim 83 (Previously presented): The microelectronic spring structure of claim 61, wherein said first material has a lower modulus of elasticity than said second material.

Claim 84 (Previously presented): The microelectronic spring structure of claim 61, wherein said over coat anchors said core element to said terminal of said substrate means.